



**THE DATASHEET OF  
PI6C2404A-1WE**



## Features

- Maximum rated frequency: 133 MHz
- Low cycle-to-cycle jitter
- Input to output delay, less than 200ps
- External feedback pin allows outputs to be synchronized to the clock input
- 5V tolerant input\*
- Operates at 3.3V  $V_{DD}$
- Test mode allows bypass of the PLL for system testing purposes (e.g., IBIS measurements)
- Space-saving Packaging (Pb-free and Green Available):  
— 8-pin, 150-mil SOIC (W)

\*  $FB\_IN$  and  $CLKIN$  must reference the same voltage thresholds for the PLL to deliver zero delay skewing

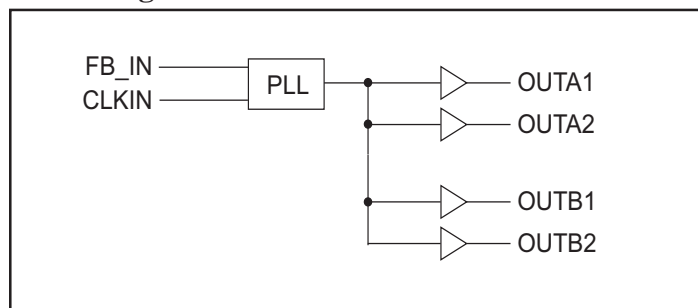
## Description

The PI6C2404A-1 is a PLL-based, zero-delay buffer, with the ability to distribute four outputs of up to 133 MHz at 3.3V. Two banks of two outputs exist,  $OUTA[1-2]$  and  $OUTB[1-2]$ .

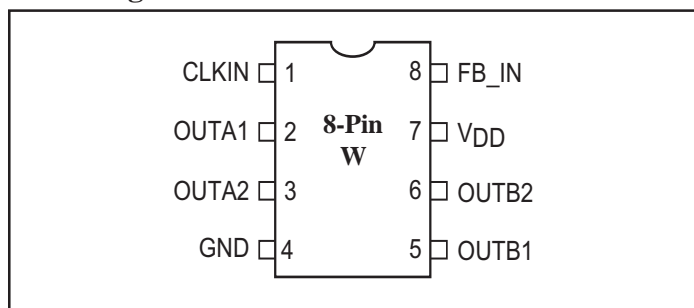
An external feedback pin is used to synchronize the outputs to the input; the relationship between loading of this signal and the other outputs determines the input-output delay.

The PI6C2404A-1 is characterized for both commercial and industrial operation.

## Block Diagram



## Pin Configuration

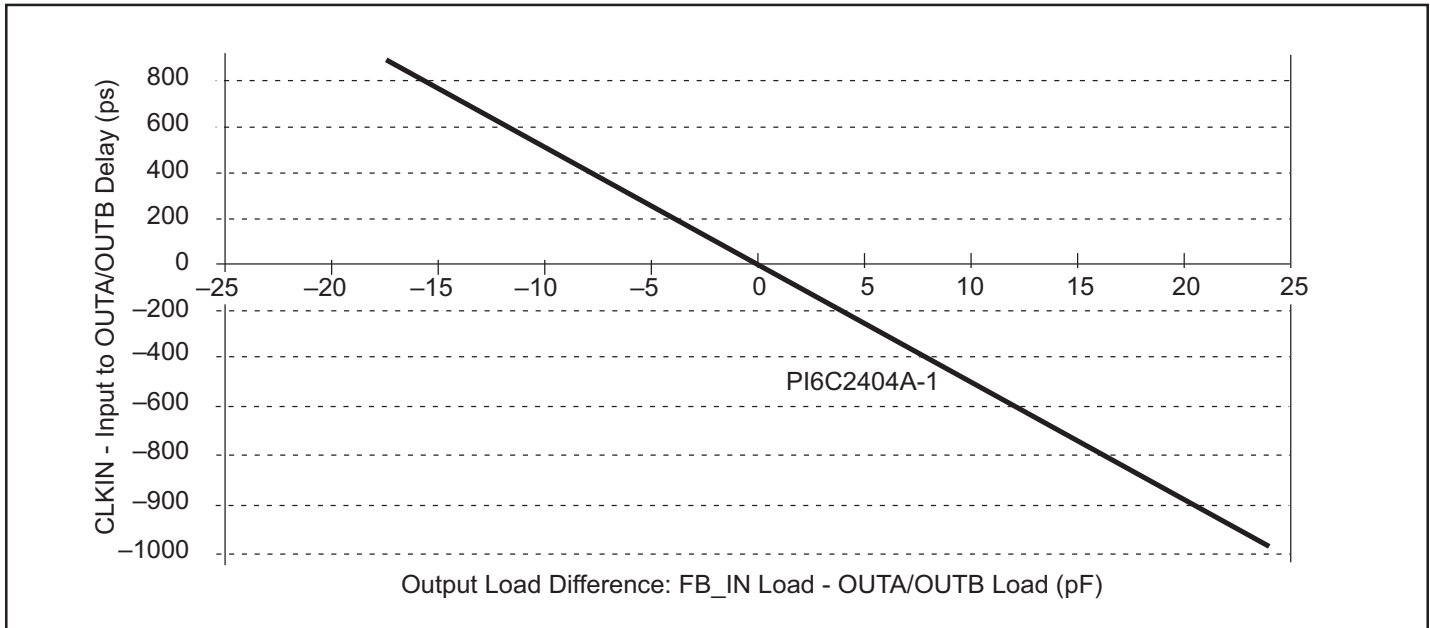


## Pin Description

| Pin  | Signal    | Description                                      |
|------|-----------|--|
| 1    | CLKIN     | Input clock reference frequency (weak pull-down) |
| 2, 3 | OUTA[1-2] | Clock output, Bank A                             |
| 7    | $V_{DD}$  | 3.3V supply                                      |
| 4    | GND       | Ground   |
| 5, 6 | OUTB[1-2] | Clock output, Bank B                             |
| 8    | FB_IN     | PLL feedback input                               |

### Zero-Delay and Skew Control

#### CLKIN Input to Output Bank Delay vs. Difference in Loading between FB\_IN pin and OUTA/OUTB pins



The relationship between loading of the FB\_IN signal and other outputs determines the input-output delay. Zero delay is achieved when all outputs, including feedback, are loaded equally.

### Maximum Ratings

|   |                                |
|---|--------------------------------|
| Supply Voltage to Ground Potential .....                      | -0.5V to +7.0V                 |
| DC Input Voltage (Except CLKIN) .....                         | -0.5V to V <sub>DD</sub> +0.5V |
| DC Input Voltage CLKIN .....                                  | -0.5 to 7V                     |
| Storage Temperature .....                                     | -65°C to +150°C                |
| Maximum Soldering Temperature (10 seconds) .....              | 260°C                          |
| Junction Temperature .....                                    | 150°C                          |
| Static Discharge Voltage (per MIL-STD-883, Method 3015) ..... | >2000V                         |

### Operating Conditions (V<sub>CC</sub>=3.3V±0.3V)

| Parameter       | Description                               | Min. | Max. | Units |
|-----------------|---|------|------|-------|
| V <sub>DD</sub> | Supply Voltage                            | 3.0  | 3.6  | V     |
| T <sub>A</sub>  | Commerical Operating Temperature          | 0    | 70   | °C    |
|                 | Industrial Operating Temperature          | -40  | 85   |       |
| C <sub>L</sub>  | Load Capacitance, below 100 MHz           | —    | 30   | pF    |
|                 | Load Capacitance, from 100 MHz to 133 MHz | —    | 15   |       |
| C <sub>IN</sub> | Input Capacitance                         | —    | 7.3  |       |

**DC Electrical Characteristics for Industrial Temperature Devices**

| Parameter       | Description         | Test Conditions   | Min. | Max. | Units |
|-----------------|---------------------|---|------|------|-------|
| V <sub>IL</sub> | Input LOW Voltage   |   |      | 0.8  | V     |
| V <sub>IH</sub> | Input HIGH Voltage  |   | 2.0  |      |       |
| I <sub>IL</sub> | Input LOW Current   | V <sub>IN</sub> = 0V  |      | 50   | μA    |
| I <sub>IH</sub> | Input HIGH Current  | V <sub>IN</sub> = V <sub>DD</sub>                                 |      | 112  |       |
| V <sub>OL</sub> | Output LOW Voltage  | I <sub>OL</sub> = 8mA   |      | 0.4  | V     |
| V <sub>OH</sub> | Output HIGH Voltage | I <sub>OH</sub> = -8mA  | 2.4  |      |       |
| I <sub>DD</sub> | Supply Current      | Unloaded outputs 100 MHz, Select inputs at V <sub>DD</sub> or GND |      | 54   | mA    |
|                 |                     | Unloaded outputs 66 MHz, CLKIN                                    |      | 39   |       |
|                 |                     | Unloaded outputs 33MHz, CLKIN                                     |      | 22   |       |

**AC Electrical Characteristics for Industrial Temperature Devices**

| Parameters         | Name   | Test Conditions   | Min. | Typ. | Max. | Units |
|--------------------|--|---|------|------|------|-------|
| F <sub>O</sub>     | Output Frequency   | 30pF load   | 10   |      | 100  | MHz   |
|                    |  | 15pF load   |      |      | 133  |       |
| t <sub>DC</sub>    | Duty Cycle <sup>(1)</sup>                                    | Measured at V <sub>DD</sub> /2, F <sub>OUT</sub> < 66.67MHz 30pF load | 40   | 50   | 60   | %     |
|                    |  | Measured at V <sub>DD</sub> /2, F <sub>OUT</sub> < 50MHz 15pF load    | 45   |      | 55   |       |
| t <sub>R</sub>     | Rise Time <sup>(1)</sup>                                     | Measured between 0.8V and 2.0V, 30pF load                             |      |      | 2.2  | ns    |
|                    |  | Measured between 0.8V and 2.0V, 15pF load                             |      |      | 1.5  |       |
| t <sub>F</sub>     | Fall Time <sup>(1)</sup>                                     | Measured between 0.8V and 2.0V, 30pF load                             |      |      | 2.2  | ns    |
|                    |  | Measured between 0.8V and 2.0V, 15pF load                             |      |      | 1.5  |       |
| t <sub>SK(O)</sub> | Output to Output Skew within same bank <sup>(1)</sup>        | All outputs equally loaded  |      |      | 200  | ps    |
|                    | OUTA to OUTB Skew <sup>(1)</sup>                             |   |      |      |      |       |
| t <sub>0</sub>     | Delay, CLKIN Rising Edge to FB_IN Rising Edge <sup>(1)</sup> | Measured at V <sub>DD</sub> /2  |      |      | 275  | ps    |
| t <sub>SK(D)</sub> | Device-to-Device Skew <sup>(1)</sup>                         | Measured at V <sub>DD</sub> /2 on FB_IN pins of devices               |      | 0    | 500  | ps    |
| t <sub>JIT</sub>   | Cycle-to-Cycle Jitter <sup>(1)</sup>                         | Measured at 66.67 MHz, loaded 30pF load                               |      |      | 200  | ps    |
|                    |  | Measured at 133 MHz, loaded 15pF load                                 |      |      | 150  |       |
| t <sub>LOCK</sub>  | PLL Lock Time <sup>(1)</sup>                                 | Stable power supply, valid clocks presented on CLKIN and FB_IN pins   |      |      | 1.0  | ms    |

**Notes:**

1. CLKIN and FB\_IN inputs have a threshold voltage of V<sub>DD</sub>/2.

**DC Electrical Characteristics for Commercial Temperature Devices**

| Parameter       | Description         | Test Conditions  | Min. | Max. | Units |
|-----------------|---------------------|--|------|------|-------|
| V <sub>IL</sub> | Input LOW Voltage   |  | —    | 0.8  | V     |
| V <sub>IH</sub> | Input HIGH Voltage  |  | 2.0  | —    |       |
| I <sub>IL</sub> | Input LOW Current   | V <sub>IN</sub> = 0V   | —    | 50   | μA    |
| I <sub>IH</sub> | Input HIGH Current  | V <sub>IN</sub> = V <sub>DD</sub>                                    | —    | 112  |       |
| V <sub>OL</sub> | Output LOW Voltage  | I <sub>OL</sub> = 8mA  | —    | 0.4  | V     |
| V <sub>OH</sub> | Output HIGH Voltage | I <sub>OH</sub> = -8mA   | 2.4  | —    |       |
| I <sub>DD</sub> | Supply Current      | Unloaded outputs 100 MHz Select Inputs @ V <sub>DD</sub> or GND      | —    | 54   |       |
| I <sub>DD</sub> | Supply Current      | Unloaded outputs, 66.67 MHz, Select inputs at V <sub>DD</sub> or GND | —    | 39   | mA    |

**AC Electrical Characteristics for Commercial Temperature Device**

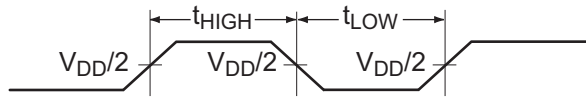
| Parameters         | Name   | Test Conditions  | Min. | Typ. | Max. | Units |
|--------------------|--|--|------|------|------|-------|
| F <sub>O</sub>     | Output Frequency   | 30pF load  | 10   |      | 100  | MHz   |
|                    |  | 15pF load,   |      |      | 133  |       |
| t <sub>DC</sub>    | Duty Cycle <sup>(2)</sup>  | Measured at V <sub>DD</sub> /2, F <sub>O</sub> < 66.67MHz, 30pF load | 40   | 50   | 60   | %     |
|                    |  | Measured at V <sub>DD</sub> /2, F <sub>O</sub> < 50MHz, 15pF load    | 45   | 50   | 55   |       |
| t <sub>R</sub>     | Rise Time <sup>(1)</sup> @ 30pF  | Measured between 0.8V and 2.0V                                       |      |      | 2.2  | ns    |
|                    | Rise Time <sup>(1)</sup> @ 15pF  |  |      |      | 1.5  |       |
| t <sub>F</sub>     | Fall Time <sup>(1)</sup> @ 30pF  |  |      |      | 2.2  |       |
|                    | Fall Time <sup>(1)</sup> @ 15pF  |  |      |      | 1.5  |       |
| t <sub>SK(O)</sub> | Output to Output Skew <sup>(1)</sup> within same bank                        | All outputs equally loaded, V <sub>DD</sub> /2                       |      |      | 200  |       |
|                    | OUTA to OUTB Skew <sup>(1)</sup>   | All outputs equally loaded, V <sub>DD</sub> /2                       |      |      | 200  |       |
| t <sub>0</sub>     | Input to Output Delay, CLKIN Rising Edge to FB_IN Rising Edge <sup>(1)</sup> | Measured at V <sub>DD</sub> /2                                       |      |      | 275  | ps    |
| t <sub>SK(D)</sub> | Device to Device Skew <sup>(1)</sup>   | Measured at V <sub>DD</sub> /2 on FB_IN pins of devices              |      | 0    | 500  |       |
| t <sub>JIT</sub>   | Cycle-to-Cycle Jitter <sup>(1)</sup>   | Measured at 66.67 MHz, loaded 30pF outputs                           |      |      | 200  |       |
|                    |  | Measured at 133 MHz, loaded 15pF outputs                             |      |      | 150  |       |
| t <sub>LOCK</sub>  | PLL Lock Time <sup>(1)</sup>   | Stable power supply, valid clocks presented on CLKIN and FB_IN pins  |      |      | 1.0  | ms    |

**Notes:**

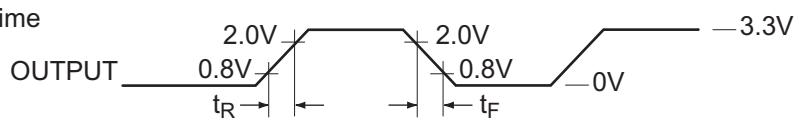
- CLKIN and FB\_IN inputs have a threshold voltage of V<sub>DD</sub>/2.
- $$t_{DC} = \frac{t_{HIGH}}{t_{HIGH} + t_{LOW}}$$

### Switching Waveforms

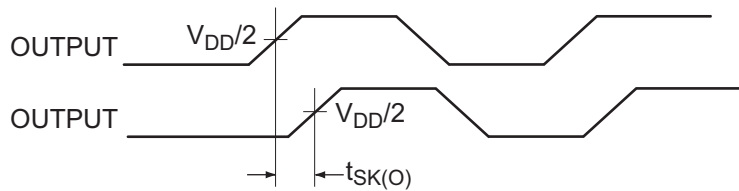
Duty Cycle Timing



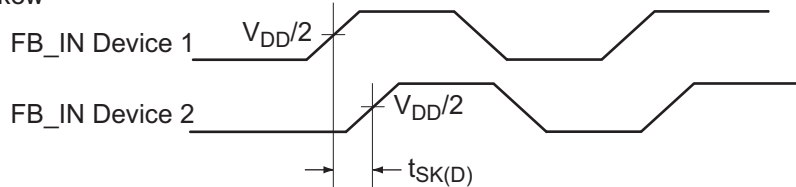
All Outputs Rise/Fall Time



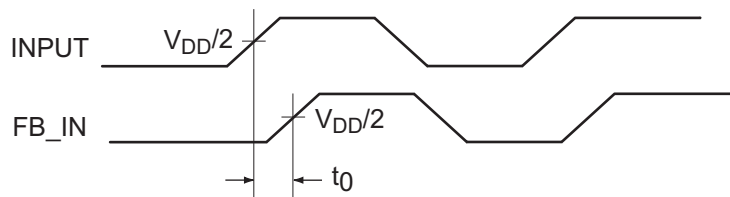
Output-Output Skew



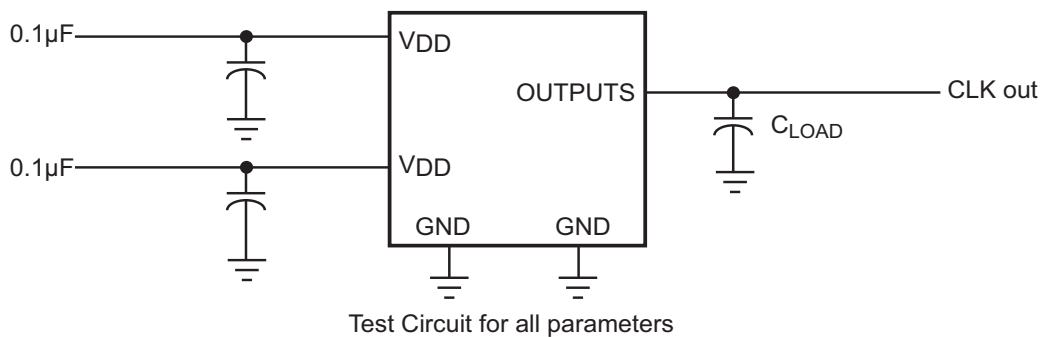
Device-Device Skew



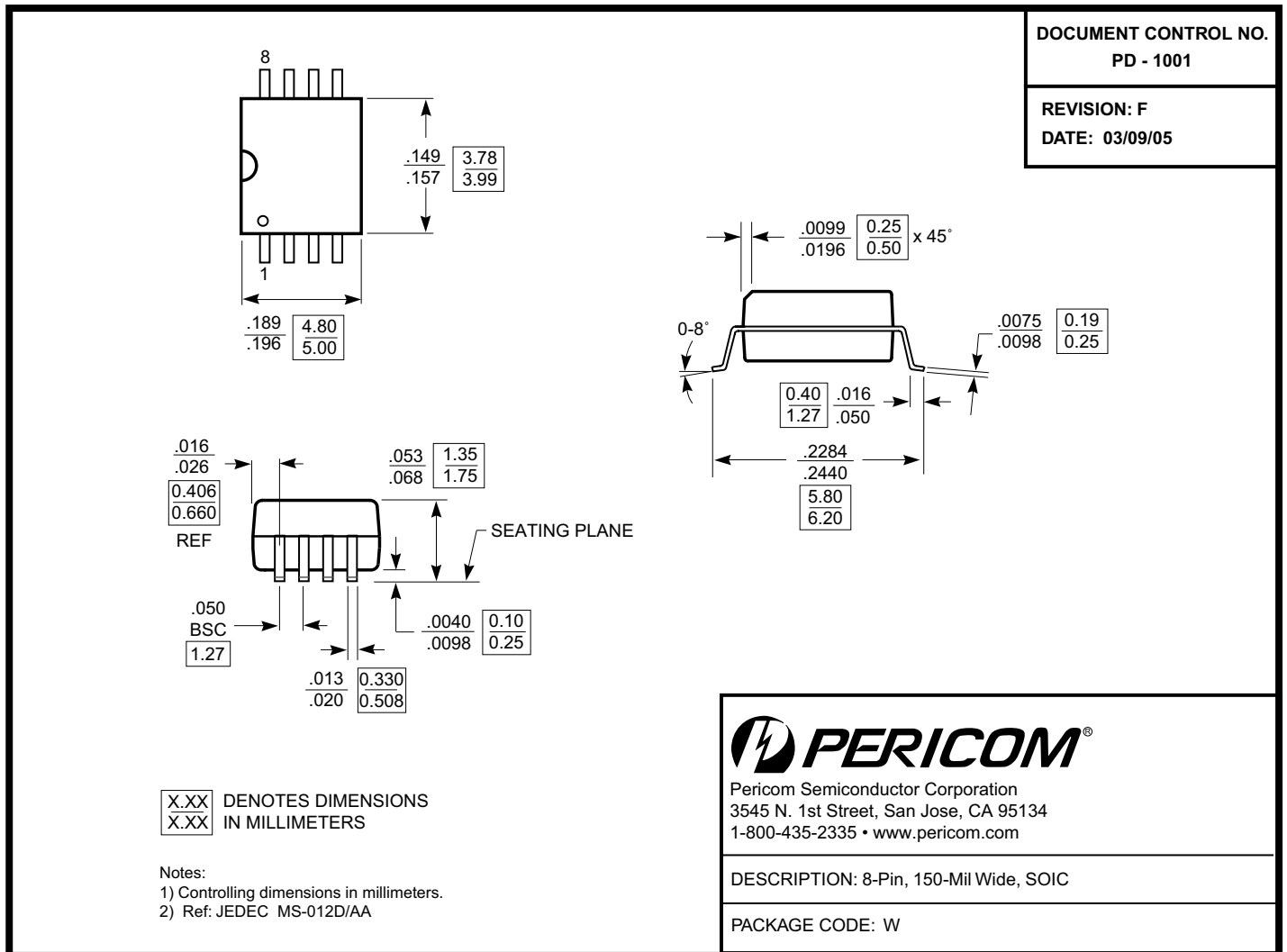
Input-Output Propagation Delay



### Test Circuit



Packaging Mechanical: 8-Pin SOIC (W)



Ordering Information



| Ordering Code  | Package Code | Package Description                     | Operating Range |
|----------------|--------------|---|-----------------|
| PI6C2404A-1WE  | W            | Pb-free and Green<br>8-pin 150-mil SOIC | Commercial      |
| PI6C2404A-1WIE | W            | Pb-free and Green<br>8-pin 150-mil SOIC | Industrial      |

Notes:

- Thermal characteristics can be found on the company web site at [www.pericom.com/packaging/](http://www.pericom.com/packaging/)
- X = Tape/Reel
- E = Pb-free & Green

## Looking for pricing, stock, or lifecycle information?

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-  Shortage Management
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